DATE Best Paper Awards

Each year the Design, Automation and Test in Europe Conference presents awards to the authors of the best papers. The selection is performed by an award committee, based on the results of the reviewing process, the quality of the final paper, and (until DATE 2012) the quality of the presentation.

The DATE 2012 best paper is:

**COMPOSITIONAL SYSTEM-LEVEL DESIGN EXPLORATION WITH PLANNING OF HIGH-LEVEL SYNTHESIS**

*Hung-Yi Liu, Michele Petracca, and Luca P. Carloni, Columbia University, US.*

The DATE 2013 best papers are:

**D Track**

**AVICA: AN ACCESS-TIME VARIATION INSENSITIVE L1 CACHE ARCHITECTURE**

*Seokin Hong and Soontea Kim - Korea Advanced Institute of Science and Technology, KR*

**A Track**

**SCC THERMAL MODEL IDENTIFICATION VIA ADVANCED BIAS-COMPENSATED LEAST-SQUARES**

*Roberto Diversi, Andrea Bartolini, Andrea Tilli, Francesco Beneventi and Luca Benini - University of Bologna, IT*

**T Track:**

**HANDLING DISCONTINUOUS EFFECTS IN MODELING SPATIAL CORRELATION OF WAFER-LEVEL ANALOG/RF TESTS**

*Ke Huang and Yiorgos Makris - University of Texas at Dallas, US*

and

*Nathan Kupp - Yale University, US*

and

*John Carulli - Texas Instruments, US*

**E Track**

**FIFO CACHE ANALYSIS FOR WCET ESTIMATION: A QUANTITATIVE APPROACH**

*Nan Guan, Xinping Yang and Wang Yi - Uppsala University, SE*

and

*Mingsong Lv - Northeastern University, CN*

Congratulations to the winners!